

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination MOTOYAMA ET AL.	
		Examiner Robert Loewe	Art Unit 1796	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,879,345 A	11-1989	Connelly et al.	525/104
*	B	US-5,800,926 A	09-1998	Nogami et al.	428/447
*	C	US-5,902,226 A	05-1999	Tasaki et al.	516/34
*	D	US-2001/0012565 A1	08-2001	Nakada et al.	428/429
*	E	US-2001/0050741 A1	12-2001	Hokazono et al.	349/137
*	F	US-6,472,012 B2	10-2002	Nakada et al.	427/58
*	G	US-2004/0115955 A1	06-2004	Motoyama et al.	438/781
*	H	US-2004/0125169 A1	07-2004	Nakagawa et al.	347/045
*	I	US-2004/0156110 A1	08-2004	Ikeyama, Akihiro	359/603
*	J	US-6,855,375 B2	02-2005	Nakagawa et al.	427/387
*	K	US-2006/0189163 A1	08-2006	Motoyama et al.	438/781
*	L	US-2006/0287460 A1	12-2006	Tani et al.	528/028
*	M	US-2007/0155897 A1	07-2007	Tani et al.	524/837

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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